


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/517,030	OOUCHIDA ET AL.	
	Examiner	Art Unit	
	F. Daniel Lopez	3745	

SEARCHED			
Class	Subclass	Date	Examiner
60	489	3/13/2006	FDL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR